## Applicant(s)/Patent Under Application/Control No. Reexamination 10/631,215 PIQUE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1763 Richard Bueker **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY 219/121.85 12-1987 Gnanamuthu et al. Α US-4,716,270 427/597 03-1994 Joyce et al. US-5,292,559 В 03-1998 Opower, Hans 427/592 US-5,725,914 C 106/31.32 US-6,099,626 08-2000 Hirano et al. D Ε US-US-F US-G US-Н US-US-J US-K US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

W

Х